

Notice of References Cited

Application/Control No.

09/183,717

Applicant(s)/Patent Under

Reexamination

DESCH, DAVID ALAN

Examiner

Vivek Srivastava

Art Unit

2611

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,956,094	09-1999	Chun, Doo-hwan	348/564
	B	US-5,969,769	10-1999	Hamadate, Shunichi	348/568
	C	US-5,327,554	07-1994	Palazzi et al.	725/110
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

KT